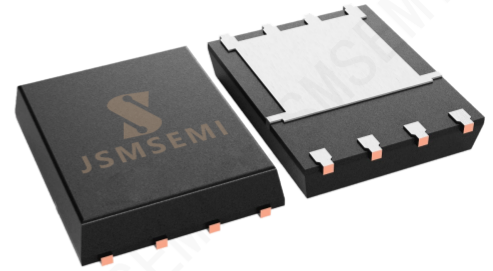


## Product Summary

- $V_{DS}$  60V
- $I_D$  100A
- $R_{DS(ON)}$  ( at  $V_{GS}=10V$ )  $< 3.4m\Omega$
- 100% EAS Tested
- 100%  $\nabla V_{DS}$  Tested

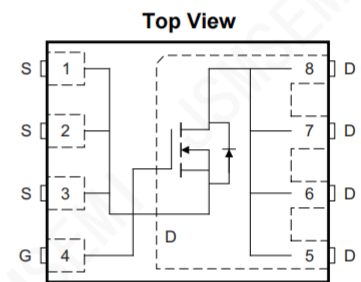


## General Description

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

## Applications

- Power switching application
- Uninterruptible power supply
- DC-DC convertor
- Motor drivers



### ■ Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		$V_{DS}$	60	V
Gate-source Voltage		$V_{GS}$	$\pm 20$	V
Drain Current	$T_C=25^\circ\text{C}$	$I_D$	100	A
	$T_C=100^\circ\text{C}$		70	
Pulsed Drain Current <sup>A</sup>		$I_{DM}$	400	A
Avalanche energy <sup>B</sup>		EAS	340	mJ
Total Power Dissipation <sup>C</sup>	$T_C=25^\circ\text{C}$	$P_D$	120	W
	$T_C=100^\circ\text{C}$		50	
Junction and Storage Temperature Range		$T_J, T_{STG}$	-55~+150	$^\circ\text{C}$

### ■ Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient <sup>D</sup>	Steady-State	$R_{\theta JA}$	35		$^\circ\text{C/W}$
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	0.85		

## Ordering Information

Order number	Package	Marking	Operation Temperature Range	MSL Grade	Ship, Quantity	Green
BSC034N06NSATMA1-JSM	DFN5060-8L	023N06QGL	-55 to $150^\circ\text{C}$	1	T&R,5000	RoHS

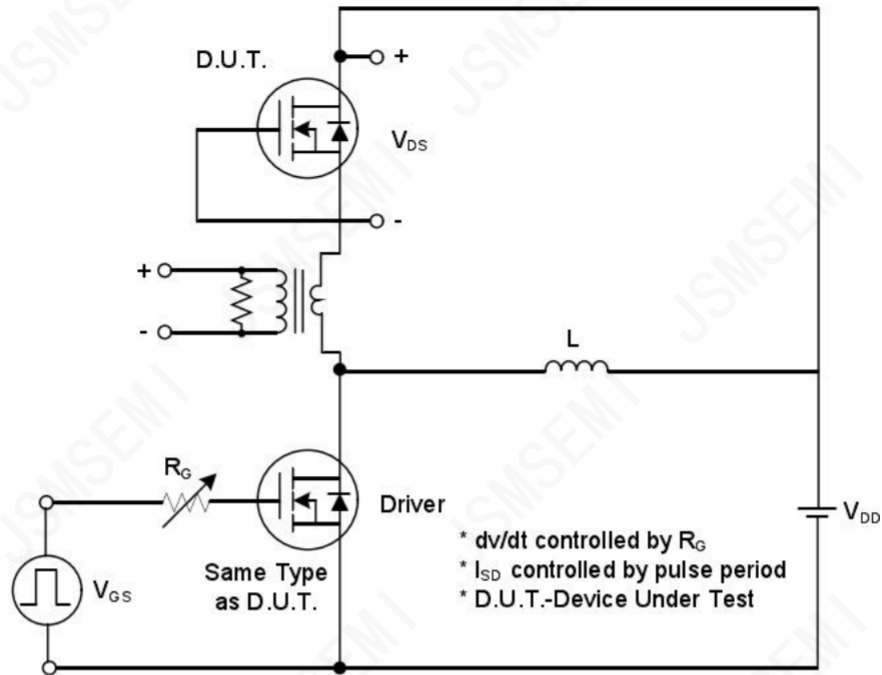
**■ Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b> <sup>(6)</sup>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60	-	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 60V, V_{GS} = 0V$		-	1.0	$\mu A$
			$T_J = 125^\circ\text{C}$	-	100	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 100$	nA
<b>On Characteristics</b> <sup>(6)</sup>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	1.3	1.7	2.5	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$	-	2.8	3.4	m $\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} = 5.0V, I_D = 20A$	-	42	-	S
Diodes Forward Voltage	$V_{SD}$	$I_S = 2.0A, V_{GS} = 0V$	-	0.7	1.2	V
<b>Dynamic Characteristics</b> <sup>(7)</sup>						
Input Capacitance	$C_{iss}$	$V_{DS} = 30V, V_{GS} = 0V, f = 1\text{MHz}$	-	3183	-	pF
Output Capacitance	$C_{oss}$		-	914	-	pF
Reverse Transfer Capacitance	$C_{rss}$		-	9	-	pF
Gate Resistance	$R_g$	$V_{GS} = 0V, V_{DS} = 0V, f = 1\text{MHz}$	-	1.8	-	$\Omega$
<b>Switching Characteristics</b> <sup>(7)</sup>						
Turn-On DelayTime	$t_{d(on)}$	$V_{GS} = 10V, V_{DS} = 30V$ $I_D = 20A, R_{GEN} = 3.0\Omega$	-	8.5	-	ns
Rise Time	$t_r$		-	18	-	ns
Turn-Off DelayTime	$t_{d(off)}$		-	65	-	ns
Fall Time	$t_f$		-	28	-	ns
<b>Gate Charge Characteristics</b> <sup>(7)</sup>						
Total Gate Charge ( $V_{GS} = 10V$ )	$Q_g$	$V_{DS} = 30V, I_D = 20A$ $V_{GS} = 10V$	-	94	-	nC
Total Gate Charge ( $V_{GS} = 6.0V$ )	$Q_g$		-	60	-	nC
Gate-Source Charge	$Q_{gs}$		-	25	-	nC
Gate-Drain Charge	$Q_{gd}$		-	23	-	nC
Gate Plateau Voltage	$V_{plateau}$		-	4.4	-	V
<b>Drain-Source Diode Characteristics</b> <sup>(7)</sup>						
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20A, dI/dt = 100A/\mu s,$	-	66	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$T_J = 25^\circ\text{C}$	-	131	-	nC
Diode Forward Current	$I_S$	$T_C = 25^\circ\text{C}$	-	-	100	A

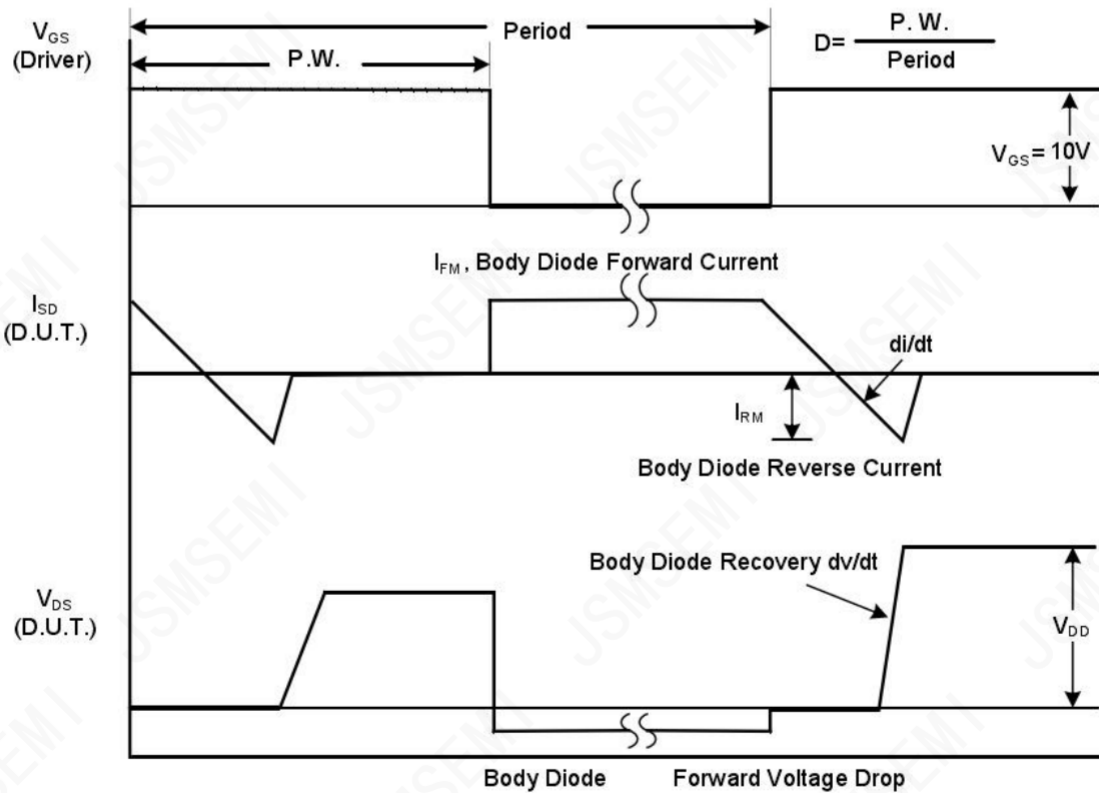
**Notes:**

1. This current is chip limited, which is calculated based on  $R_{thjc}$ .
2. This current is calculated on single pulse with 10 $\mu s$  Single Pulse.
3. Defined by design, not subject to production test,  $E_{AS}$  condition:  $T_J=25^\circ\text{C}, V_{DD}=30V, V_{GS}=10V, L=1.0\text{mH}$ .
4. Device mounted on FR-4 substrate PC board with 2oz copper in 1inch square cooling area.
5. Thermal resistance from junction to the exposed drain pad.
6. Short duration pulse test used to minimize self-heating effect.
7. Defined by design, not subject to production.

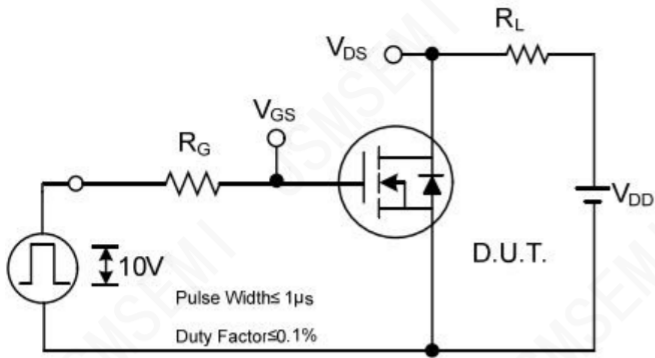
■ RATING AND CHARACTERISTIC CURVES



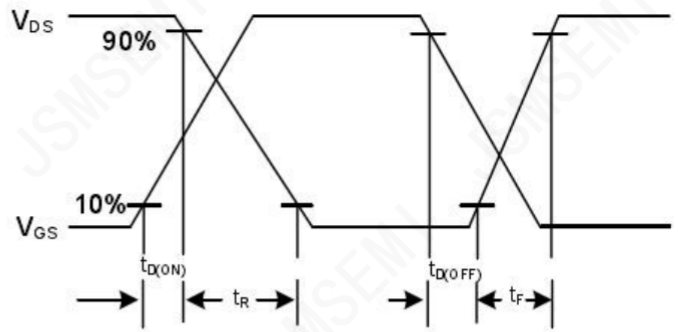
Peak Diode Recovery  $dv/dt$  Test Circuit



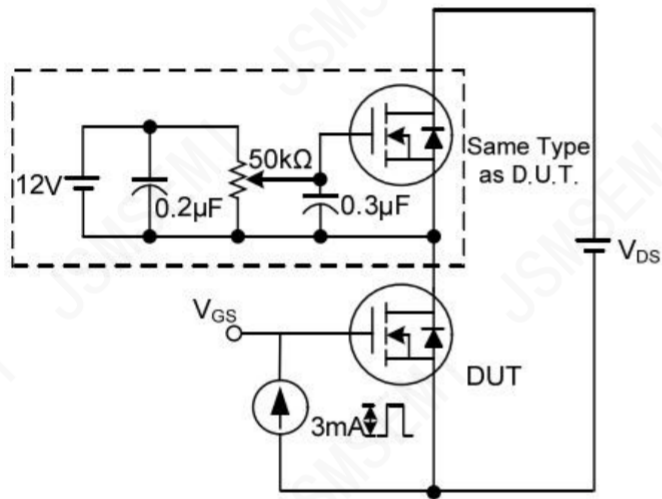
Peak Diode Recovery  $dv/dt$  Waveforms



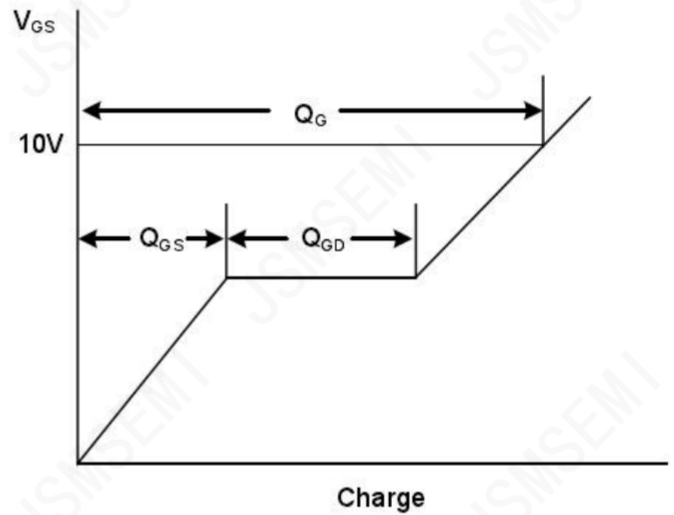
Switching Test Circuit



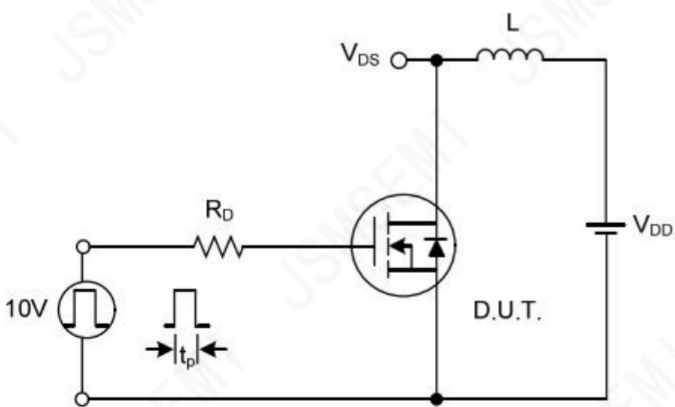
Switching Waveforms



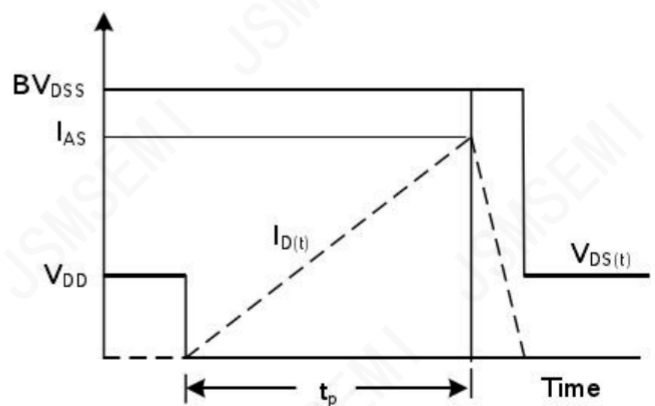
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ Typical Electrical and Thermal Characteristics Diagrams

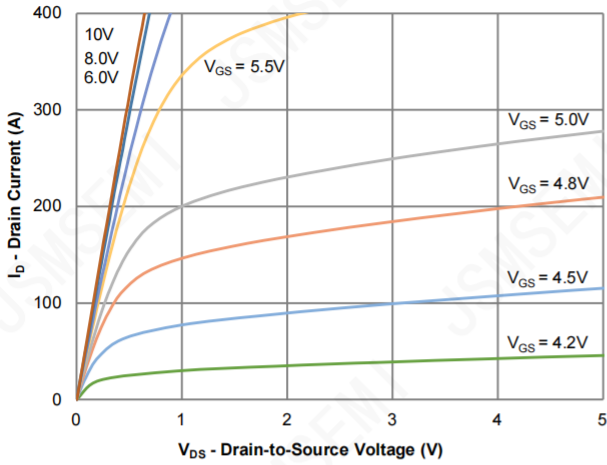


Figure 1: Output Characteristics

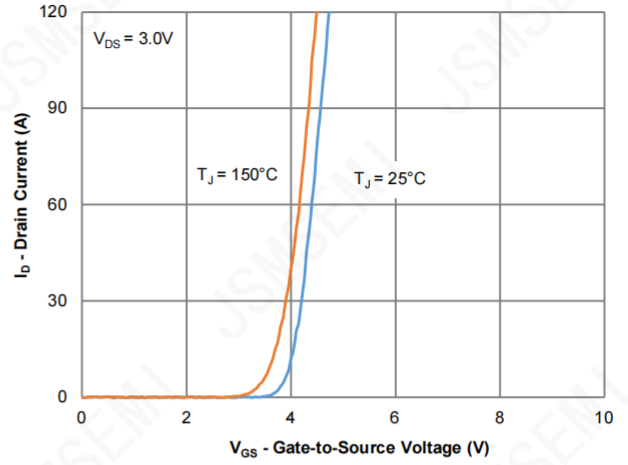


Figure 2: Transfer Characteristics

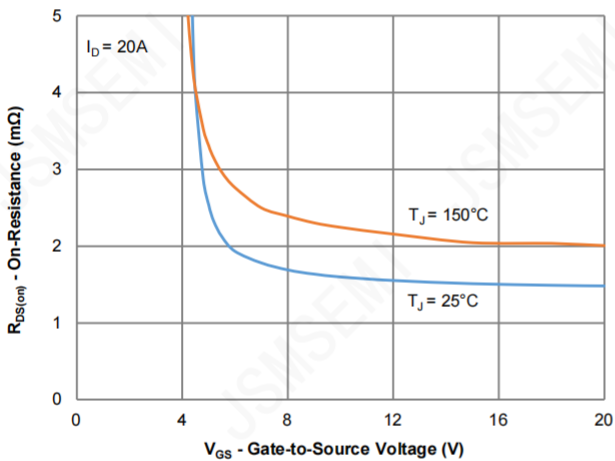


Figure 3: On-Resistance vs. Gate-Source Voltage

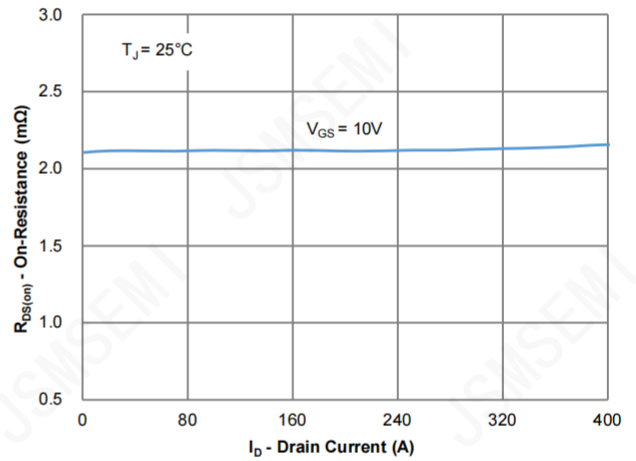


Figure 4: On-Resistance vs. Drain Current and Gate Voltage

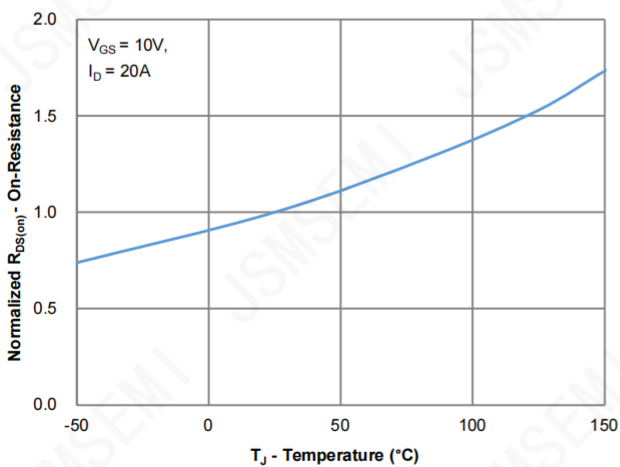


Figure 5: On-Resistance vs. Junction Temperature

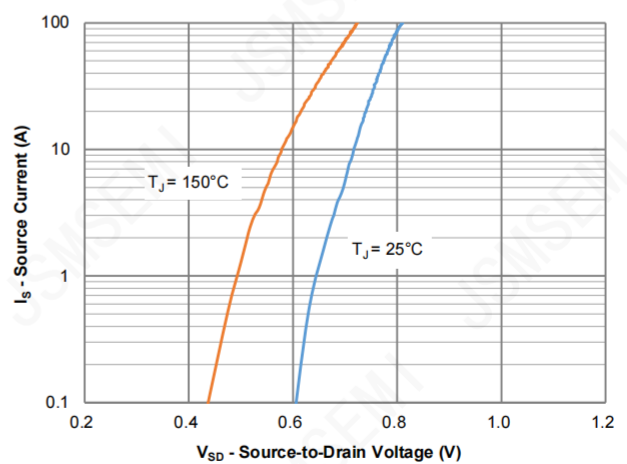


Figure 6: Source-Drain Diode Forward Voltage

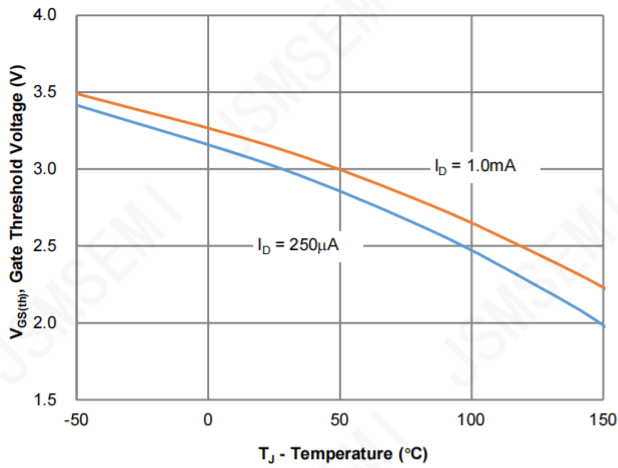


Figure 7: Gate Threshold Variation vs. Junction Temperature

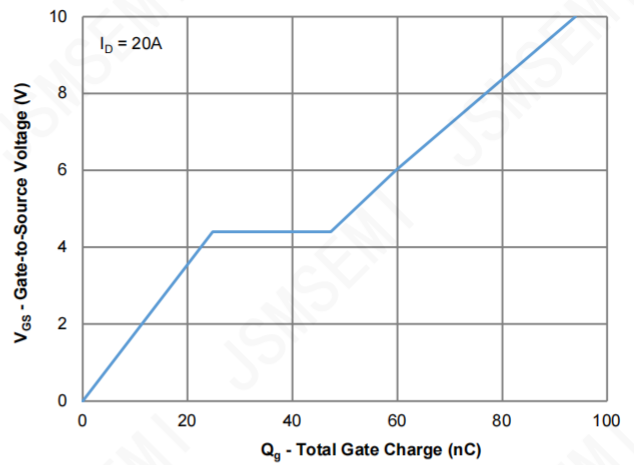


Figure 8: Gate Charge Characteristics

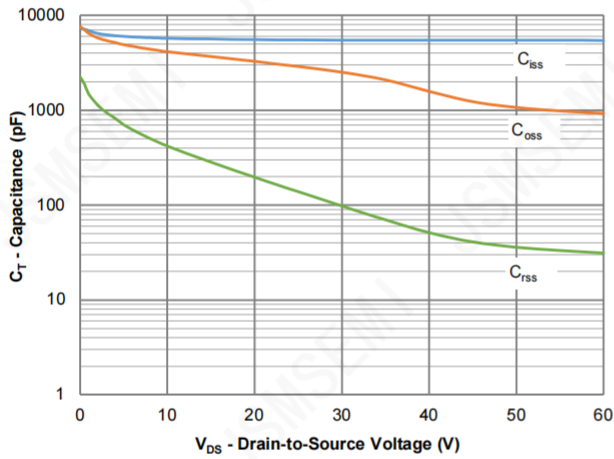


Figure 9: Capacitance Characteristics

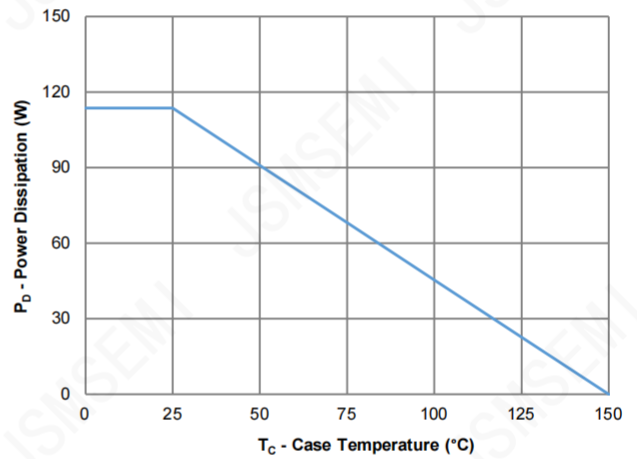


Figure 10: Power Derating

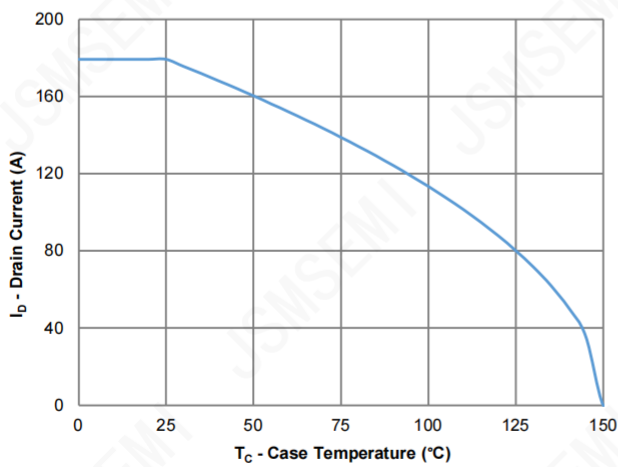


Figure 11: Current Derating

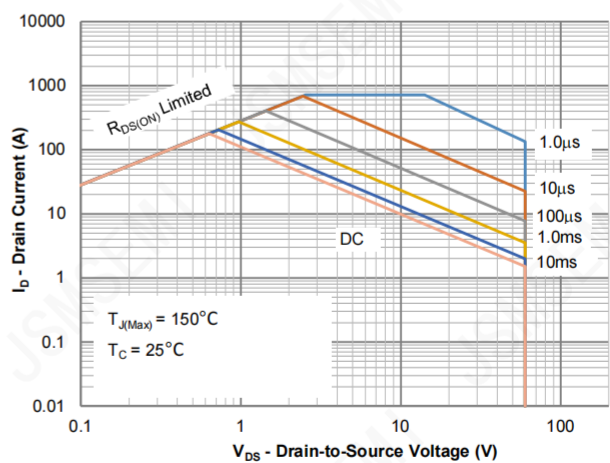


Figure 12: Safe Operating Area

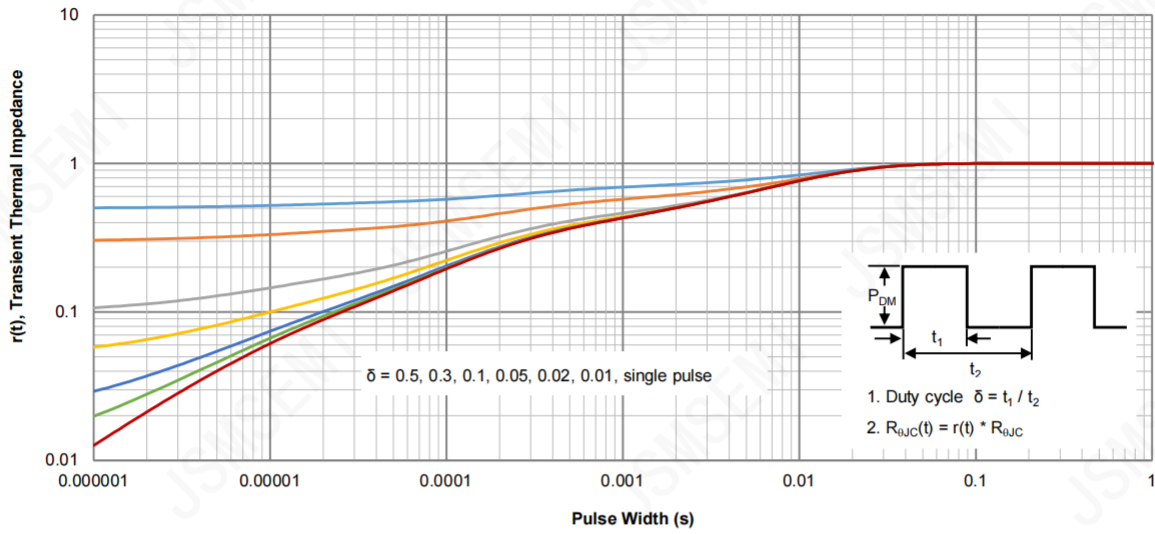
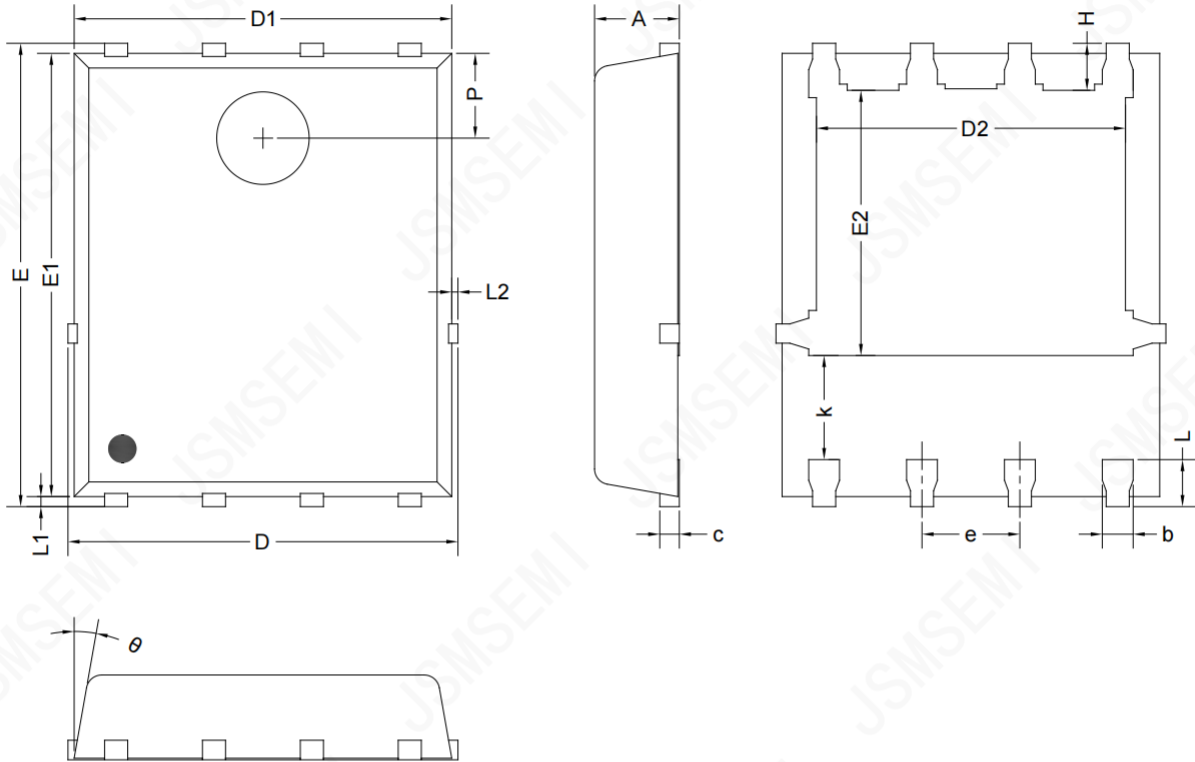


Figure 13: Normalized Maximum Transient Thermal Impedance

**Package Information**
**DFN5060-8L**


Symbol	Dimensions In Millimeters		
	MIN	NOM	MAX
A	1.000	1.100	1.200
b	0.350	0.400	0.450
c	0.210	0.250	0.340
D	4.800	-	5.100
D1	4.800	4.900	5.000
D2	3.910	4.010	4.110
E	5.900	6.000	6.100
E1	5.700	5.750	5.800
E2	3.340	3.440	3.540
e	1.270 BSC		
H	0.510	0.610	0.710
k	1.100	-	-
L	0.510	0.610	0.710
L1	0.060	0.130	0.200
L2	-	-	0.100
P	1.000	1.100	1.200
θ	8°	10°	12°

NOTE: This drawing is subject to change without notice.

## Revision History

Rev.	Change	Date
V1.0	Initial version	6/27/2021

## Important Notice

JSMSEMI Semiconductor (JSMSEMI) PRODUCTS ARE NEITHER DESIGNED NOR INTENDED FOR USE IN MILITARY AND/OR AEROSPACE, AUTOMOTIVE OR MEDICAL DEVICES OR SYSTEMS UNLESS THE SPECIFIC JSMSEMI PRODUCTS ARE SPECIFICALLY DESIGNATED BY JSMSEMI FOR SUCH USE. BUYERS ACKNOWLEDGE AND AGREE THAT ANY SUCH USE OF JSMSEMI PRODUCTS WHICH JSMSEMI HAS NOT DESIGNATED FOR USE IN MILITARY AND/OR AEROSPACE, AUTOMOTIVE OR MEDICAL DEVICES OR SYSTEMS IS SOLELY AT THE BUYER' S RISK.

JSMSEMI assumes no liability for application assistance or customer product design. Customers are responsible for their products and applications using JSMSEMI products.

Resale of JSMSEMI products or services with statements diferent from or beyond the parameters stated by JSMSEMI for that product or service voids all express and any implied warranties for the associated JSMSEMI product or s ervice. JSMSEMI is not responsible or liable for any such statements.

JSMSEMI All Rights Reserved. Information and data in this document are owned by JSMSEMI wholly and may not be edited, reproduced, or redistributed in any way without the express written consent from JSMSEMI.

Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the JSMSEMI product that you intend to use.

For additional information please contact [Kevin@jsmsemi.com](mailto:Kevin@jsmsemi.com) or visit [www.jsmsemi.com](http://www.jsmsemi.com)